



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

WARREN M. FARNWORTH
SALMAN AKRAM

Serial No. 09/266,237

Art Unit: 2829

Filing Date: March 10, 1999

Examiner: KOBERT, R.

For: TEST INTERCONNECT AND TEST SYSTEM
FOR BUMPED SEMICONDUCTOR COMPONENTS
(AS AMENDED)

Attorney Docket No. 97-1433

AMENDMENT

April 26, 2004

Mail Stop Non-Fee Amendment
Commissioner For Patents
PO Box 1450
Alexandria, VA 22313-1450

Sir:

This Amendment is in response to the Office Action dated 03/26/2004, having a statutory period for response set to expire on 06/26/2004.

AMENDMENTS TO THE DRAWINGS

Please amend Figures 7A-7G per the attached replacement sheet to correct an informality ("14B" should be --12B--)